

## Features

- Wide Power Supply Range, 3.0 VDC to 5.5 VDC
- Compatible with JEDEC Standard AT27C040
- Low Power 3-Volt CMOS Operation
  - 100  $\mu$ A max. Standby
  - 26 mW max. Active at 1 MHz for  $V_{CC} = 3.3$  VDC
  - 138 mW max. Active at 5 MHz for  $V_{CC} = 5.5$  VDC
- Read Access Time - 200 ns
- Wide Selection of JEDEC Standard Packages Including OTP
  - 32-Lead, 600-mil Cerdip and OTP Plastic DIP, or TSOP
  - 32-Pad LCC and OTP PLCC
- High Reliability CMOS Technology
  - 2000 V ESD Protection
  - 200 mA Latchup Immunity
- Rapid Programming - 100  $\mu$ s/byte (typical)
- Two-line Control
- CMOS and TTL Compatible Inputs and Outputs
- Integrated Product Identification Code
- Commercial and Industrial Temperature Ranges

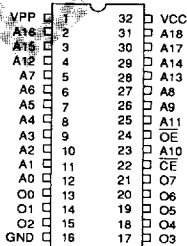
## Description

The AT27LV040 chip is a low power, low voltage 4,194,304 bit Ultraviolet Erasable and Electrically Programmable Read Only Memory (EPROM) organized as 512K x 8 bits. It requires only one supply in the range of 3.0 to 5.5 VDC in normal read mode operation, making it ideal for battery powered systems.

With a typical power draw of only 18 mW at 1 MHz and  $V_{CC}$  at 3.3 VDC, the AT27LV040 will draw less than one-fifth the power of a standard 5-volt EPROM. Standby mode supply current is typically less than 10  $\mu$ A.

*continued on next page*

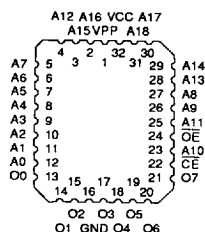
CDIP, PDIP Top View



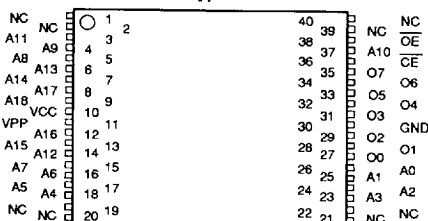
## Pin Configurations

Pin Name	Function
A0-A18	Addresses
O0-O7	Outputs
CE	Chip Enable
OE	Output Enable

PLCC, LCC Top View



TSOP Top View  
Type 1



**4 Megabit  
(512K x 8)  
Low Voltage  
UV  
Erasable  
CMOS  
EPROM**

**Preliminary**



## Description (Continued)

The AT27LV040 comes in a choice of industry standard JEDEC-approved through hole and surface mount packages including windowed and one time programmable (OTP) packages, such as the OTP thin small outline package (TSOP). All devices feature two line control ( $\overline{CE}$ ,  $\overline{OE}$ ) to give designers the flexibility to prevent bus contention.

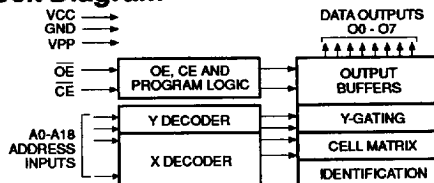
The AT27LV040 operating with  $V_{CC}$  at 3.0 VDC produces TTL level outputs that are compatible with standard TTL logic devices operating at  $V_{CC} = 5.0$  VDC.

Atmel's 27LV040 has additional features to ensure high quality and efficient production use. The Rapid Programming Algorithm reduces the time required to program the part and guarantees reliable programming. Programming time is typically only 100  $\mu$ s/byte. The Integrated Product Identification Code electronically identifies the device and manufacturer. This feature is used by industry standard programming equipment to select the proper programming algorithms and voltages. The AT27LV040 programs identically as an AT27C040.

## Erasure Characteristics

The entire memory array of the AT27LV040 is erased (all outputs read as  $V_{OH}$ ) after exposure to ultraviolet light at a wavelength of 2537 Å. Complete erasure is assured after a minimum of 20 minutes exposure using 12,000  $\mu$ W/cm<sup>2</sup> intensity lamps spaced one inch away from the chip. Minimum erase time for lamps at other intensity ratings can be calculated from the minimum integrated erasure dose of 15 W-sec/cm<sup>2</sup>. To prevent unintentional erasure, an opaque label is recommended to cover the clear window on any UV erasable EPROM which will be subjected to continuous fluorescent indoor lighting or sunlight.

## Block Diagram



## Absolute Maximum Ratings\*

Temperature Under Bias .....	-40°C to +85°C
Storage Temperature .....	-65°C to +125°C
Voltage on Any Pin with Respect to Ground .....	-2.0 V to +7.0 V <sup>(1)</sup>
Voltage on A9 with Respect to Ground .....	-2.0 V to +14.0 V <sup>(1)</sup>
$V_{PP}$ Supply Voltage with Respect to Ground .....	-2.0 V to +14.0 V <sup>(1)</sup>
Integrated UV Erase Dose .....	7258 W-sec/cm <sup>2</sup>

\*NOTICE: Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

### Notes:

1. Minimum voltage is -0.6 V dc which may undershoot to -2.0 V for pulses of less than 20 ns. Maximum output pin voltage is  $V_{CC} + 0.75$  V dc which may be exceeded if certain precautions are observed (consult application notes) and which may overshoot to +7.0 V for pulses of less than 20 ns.

## Operating Modes

Mode \ Pin	$\overline{CE}$	$\overline{OE}$	Ai	$V_{PP}$	$V_{CC}$	Outputs
Read	$V_{IL}$	$V_{IL}$	Ai	X <sup>(1)</sup>	$V_{CC}$	DOUT
Output Disable	X	$V_{IH}$	X	X	$V_{CC}$	High Z
Standby	$V_{IH}$	X	X	X	$V_{CC}$	High Z
Fast Program <sup>(2)</sup>	$V_{IL}$	$V_{IH}$	Ai	$V_{PP}$	$V_{CC}$	DIN
PGM Verify	X	$V_{IL}$	Ai	$V_{PP}$	$V_{CC}$	DOUT
PGM Inhibit	$V_{IH}$	$V_{IH}$	X	$V_{PP}$	$V_{CC}$	High Z
Product Identification <sup>(4)</sup>	$V_{IL}$	$V_{IL}$	A9= $V_{IH}$ <sup>(3)</sup> A0= $V_{IH}$ or $V_{IL}$ A1-A18= $V_{IL}$	X	$V_{CC}$	Identification Code

- Notes: 1. X can be  $V_{IL}$  or  $V_{IH}$ .  
2. Refer to Programming characteristics.  
3.  $V_{IH} = 12.0 \pm 0.5$  V.

4. Two identifier bytes may be selected. All Ai inputs are held low ( $V_{IL}$ ), except A9 which is set to  $V_{IH}$  and A0 which is toggled low ( $V_{IL}$ ) to select the Manufacturer's Identification byte and high ( $V_{IH}$ ) to select the Device Code byte.

## D.C. and A.C. Operating Conditions for Read Operation

		AT27LV040		
		-20	-25	-30
Operating Temperature (Case)	Com.	0°C - 70°C	0°C - 70°C	0°C - 70°C
	Ind.	-40°C - 85°C	-40°C - 85°C	-40°C - 85°C
Vcc Power Supply		3.0 V to 5.5 V	3.0 V to 5.5 V	3.0 V to 5.5 V

## D.C. and Operating Characteristics for Read Operation

(VCC = 3.0 V to 5.5 V unless otherwise specified)

Symbol	Parameter	Condition	Min	Max	Units
I <sub>LI</sub>	Input Load Current	V <sub>IN</sub> = -0.1 V to V <sub>CC</sub> +1 V		5	μA
I <sub>LO</sub>	Output Leakage Current	V <sub>OUT</sub> = -0.1 V to V <sub>CC</sub> +0.1 V		10	μA
I <sub>PP1</sub> <sup>(2)</sup>	V <sub>PP</sub> <sup>(1)</sup> Read/Standby Current	V <sub>PP</sub> = V <sub>CC</sub> -0.7 V to V <sub>CC</sub> +0.3 V		10	μA
I <sub>SB</sub>	V <sub>CC</sub> <sup>(1)</sup> Standby Current	I <sub>SB1</sub> (CMOS), CE = V <sub>CC</sub> -0.3 to V <sub>CC</sub> +1.0 V		100	μA
		I <sub>SB2</sub> (TTL), CE = 2.0 to V <sub>CC</sub> +1.0 V		1	mA
I <sub>CC</sub>	V <sub>CC</sub> Active Current	I <sub>CC1</sub> f = 5 MHz, I <sub>OUT</sub> = 0 mA, CE = V <sub>IL</sub> , V <sub>CC</sub> = 5.5 V	Com.	25	mA
			Ind.	30	mA
		I <sub>CC2</sub> f = 1 MHz, I <sub>OUT</sub> = 0 mA CE = V <sub>IL</sub> , V <sub>CC</sub> = 3.3 V	Com.	8	mA
			Ind.	10	mA
V <sub>IL</sub>	Input Low Voltage		-0.6	0.8	V
V <sub>IH</sub>	Input High Voltage		2.0	V <sub>CC</sub> +0.75	V
V <sub>OL</sub>	Output Low Voltage	I <sub>OL</sub> = 2.1 mA		.45	V
V <sub>OH</sub>	Output High Voltage	I <sub>OH</sub> = -100 μA		V <sub>CC</sub> -0.3	V
		I <sub>OH</sub> = -400 μA		2.4	V

Notes: 1. V<sub>CC</sub> must be applied simultaneously or before V<sub>PP</sub>, and removed simultaneously or after V<sub>PP</sub>.2. V<sub>PP</sub> may be connected directly to V<sub>CC</sub>, except during programming. The supply current would then be the sum of I<sub>CC</sub> and I<sub>PP</sub>.

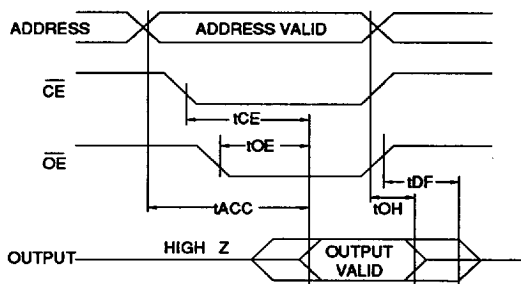
## A.C. Characteristics for Read Operation (VCC = 3.0V to 5.5V)

			AT27LV040						
			-20		-25		-30		
Symbol	Parameter	Condition	Min	Max	Min	Max	Min	Max	Units
tACC <sup>(3)</sup>	Address to Output Delay	$\overline{CE} = \overline{OE} = V_{IL}$	200		250		270		ns
tCE <sup>(2)</sup>	$\overline{CE}$ to Output Delay	$\overline{OE} = V_{IL}$	200		250		300		ns
tOE <sup>(2,3)</sup>	$\overline{OE}$ to Output Delay	$\overline{CE} = V_{IL}$	100		120		150		ns
tDF <sup>(4,5)</sup>	$\overline{OE}$ High to Output Float	$\overline{CE} = V_{IL}$	50		50		50		ns
tOH	Output Hold from Address, $\overline{CE}$ or $\overline{OE}$ , whichever occurred first	$\overline{CE} = \overline{OE} = V_{IL}$	0		0		0		ns

Notes: 2, 3, 4, 5. - see AC Waveforms for Read Operation.



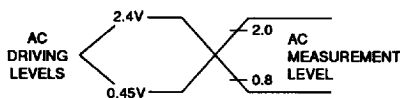
## A.C. Waveforms for Read Operation <sup>(1)</sup>



### Notes:

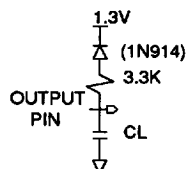
1. Timing measurement references are 0.8 V and 2.0 V. Input AC driving levels are 0.45 V and 2.4 V. See Input Test Waveforms and Measurement Levels.
2.  $\overline{OE}$  may be delayed up to  $t_{CE-tOE}$  after the falling edge of  $\overline{CE}$  without impact on  $t_{CE}$ .
3.  $\overline{OE}$  may be delayed up to  $t_{ACC-tOE}$  after the address is valid without impact on  $t_{ACC}$ .
4. This parameter is only sampled and is not 100% tested.
5. Output float is defined as the point when data is no longer driven.

## Input Test Waveforms and Measurement Levels



$t_R, t_F < 20$  ns (10% to 90%)

## Output Test Load



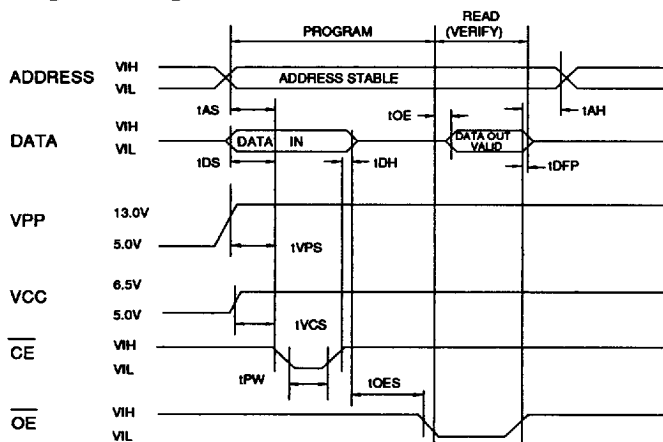
Note:  $C_L = 100$  pF including jig capacitance.

## Pin Capacitance ( $f = 1$ MHz, $T = 25^\circ\text{C}$ ) <sup>(1)</sup>

	Typ	Max	Units	Conditions
$C_{IN}$	4	8	pF	$V_{IN} = 0$ V
$C_{OUT}$	8	12	pF	$V_{OUT} = 0$ V

Notes: 1. Typical values for 5-V supply voltage. This parameter is only sampled and is not 100% tested.

## Programming Waveforms <sup>(1)</sup>



### Notes:

1. The Input Timing Reference is 0.8 V for  $V_{IL}$  and 2.0 V for  $V_{IH}$ .
2.  $t_{OE}$  and  $t_{DF}$  are characteristics of the device but must be accommodated by the programmer.
3. When programming the AT27LV040 a 0.1- $\mu\text{F}$  capacitor is required across  $V_{PP}$  and ground to suppress spurious voltage transients.

## D.C. Programming Characteristics

$T_A = 25 \pm 5^\circ\text{C}$ ,  $V_{CC} = 6.5 \pm 0.25\text{ V}$ ,  $V_{PP} = 13.0 \pm 0.25\text{ V}$

Sym- bol	Parameter	Test Conditions	Limits		Units
			Min	Max	
$I_{LI}$	Input Load Current	$V_{IN}=V_{IL}, V_{IH}$		10	$\mu\text{A}$
$V_{IL}$	Input Low Level	(All Inputs)	-0.6	0.8	V
$V_{IH}$	Input High Level		2.0	$V_{CC}+1$	V
$V_{OL}$	Output Low Volt.	$I_{OL}=2.1\text{ mA}$		.45	V
$V_{OH}$	Output High Volt.	$I_{OH}=400\text{ }\mu\text{A}$	2.4		V
$I_{CC2}$	$V_{CC}$ Supply Current (Program and Verify)			40	mA
$I_{PP2}$	$V_{PP}$ Supply Current	$\overline{CE}=V_{IL}$		20	mA
$V_{ID}$	A9 Product Identification Voltage		11.5	12.5	V

## A.C. Programming Characteristics

$T_A = 25 \pm 5^\circ\text{C}$ ,  $V_{CC} = 6.5 \pm 0.25\text{ V}$ ,  $V_{PP} = 13.0 \pm 0.25\text{ V}$

Sym- bol	Parameter	Test Conditions* (see Note 1)	Limits		Units
			Min	Max	
$t_{AS}$	Address Setup Time		2		$\mu\text{s}$
$t_{OES}$	$\overline{OE}$ Setup Time		2		$\mu\text{s}$
$t_{DS}$	Data Setup Time		2		$\mu\text{s}$
$t_{AH}$	Address Hold Time		0		$\mu\text{s}$
$t_{DH}$	Data Hold Time		2		$\mu\text{s}$
$t_{DFP}$	$\overline{OE}$ High to Out- put Float Delay	(Note 2)	0	130	ns
$t_{VPS}$	$V_{PP}$ Setup Time		2		$\mu\text{s}$
$t_{VCS}$	$V_{CC}$ Setup Time		2		$\mu\text{s}$
$t_{PW}$	$\overline{CE}$ Program Pulse Width	(Note 3)	95	105	$\mu\text{s}$
$t_{OE}$	Data Valid from $\overline{OE}$	(Note 2)		150	ns

### \*A.C. Conditions of Test:

Input Rise and Fall Times (10% to 90%) ..... 20 ns  
 Input Pulse Levels ..... 0.45 V to 2.4 V  
 Input Timing Reference Level ..... 0.8 V to 2.0 V  
 Output Timing Reference Level ..... 0.8 V to 2.0 V

### Notes:

- $V_{CC}$  must be applied simultaneously or before  $V_{PP}$  and removed simultaneously or after  $V_{PP}$ .
- This parameter is only sampled and is not 100% tested. Output Float is defined as the point where data is no longer driven — see timing diagram.
- Program Pulse width tolerance is  $100\text{ }\mu\text{sec} \pm 5\%$ .

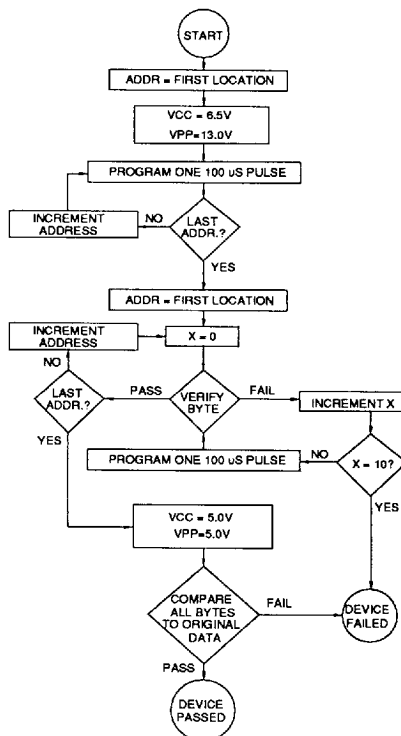
## Atmel's 27LV040 Integrated Product Identification Code<sup>(1)</sup>

Codes	Pins								Hex Data
	A0	O7	O6	O5	O4	O3	O2	O1	O0
Manufacturer	0	0	0	0	1	1	1	1	0
Device Type	1	0	0	0	0	1	0	1	1

Note: 1. The AT27LV040 has the same Product Identification Code as the AT27C040. Both are programming compatible.

## Rapid Programming Algorithm

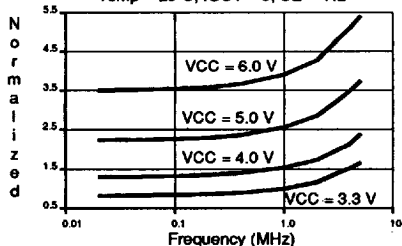
A  $100\text{ }\mu\text{s}$   $\overline{CE}$  pulse width is used to program. The address is set to the first location.  $V_{CC}$  is raised to 6.5 V and  $V_{PP}$  is raised to 13.0 V. Each address is first programmed with one  $100\text{ }\mu\text{s}$   $\overline{CE}$  pulse without verification. Then a verification/reprogramming loop is executed for each address. In the event a byte fails to pass verification, up to 10 successive  $100\text{ }\mu\text{s}$  pulses are applied with a verification after each pulse. If the byte fails to verify after 10 pulses have been applied, the part is considered failed. After the byte verifies properly, the next address is selected until all have been checked.  $V_{PP}$  is then lowered to 5.0 V and  $V_{CC}$  to 5.0 V. All bytes are read again and compared with the original data to determine if the device passes or fails.



# LV EPROM Product Characteristics

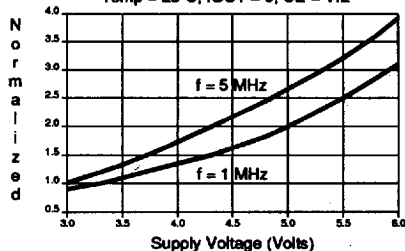
**NORMALIZED SUPPLY CURRENT vs. FREQUENCY**

Temp = 25°C, I<sub>OUT</sub> = 0, CE = VIL

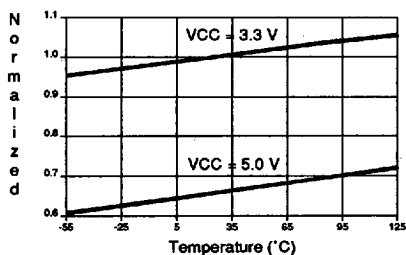


**NORMALIZED SUPPLY CURRENT vs. VOLTAGE**

Temp = 25°C, I<sub>OUT</sub> = 0, CE = VIL

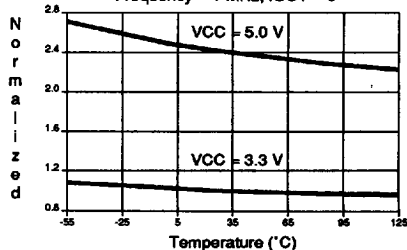


**NORMALIZED ACCESS TIME vs. TEMPERATURE**



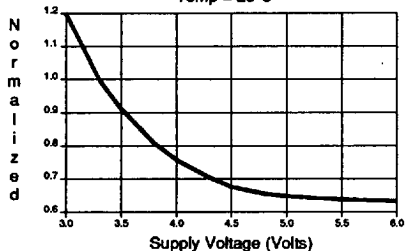
**NORMALIZED SUPPLY CURRENT vs. TEMP.**

Frequency = 1 MHz, I<sub>OUT</sub> = 0



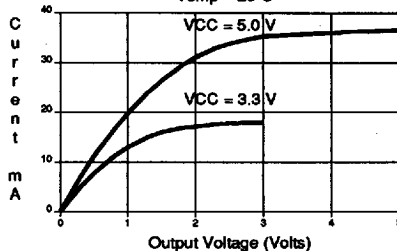
**NORMALIZED ACCESS TIME vs. SUPPLY VOLTAGE**

Temp = 25°C



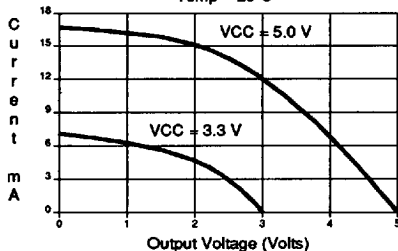
**OUTPUT SINK CURRENT vs. OUTPUT VOLTAGE**

Temp = 25°C



**OUTPUT SOURCE CURRENT vs. OUTPUT VOLTAGE**

Temp = 25°C



**Ordering Information**

t <sub>ACC</sub> (ns)	I <sub>CC</sub> (mA) V <sub>CC</sub> = 3.3 V		Ordering Code	Package	Operation Range
	Active	Standby			
200	8	0.1	AT27LV040-20DC AT27LV040-20LC	32DW6 32LW	Commercial (0°C to 70°C)
200	10	0.1	AT27LV040-20DI AT27LV040-20LI	32DW6 32LW	Industrial (-40°C to 85°C)
250	8	0.1	AT27LV040-25DC AT27LV040-25LC	32DW6 32LW	Commercial (0°C to 70°C)
250	10	0.1	AT27LV040-25DI AT27LV040-25LI	32DW6 32LW	Industrial (-40°C to 85°C)
300	8	0.1	AT27LV040-30DC AT27LV040-30JC AT27LV040-30LC AT27LV040-30PC	32DW6 32J 32LW 32P6	Commercial (0°C to 70°C)
300	10	0.1	AT27LV040-30DI AT27LV040-30LI	32DW6 32LW	Industrial (-40°C to 85°C)

**4**

t <sub>ACC</sub> (ns)	I <sub>CC</sub> (mA) V <sub>CC</sub> = 3.3 V		Ordering Code	Package	Operation Range
	Active	Standby			
250	8	0.1	AT27LV040-25TC	40T	Commercial (0°C to 70°C)
300	8	0.1	AT27LV040-30TC	40T	Commercial (0°C to 70°C)

Package Type	
<b>32DW6</b>	32 Lead, 0.600" Wide, Windowed, Ceramic Dual Inline Package (Cerdip)
<b>32J</b>	32 Lead, Plastic J-Leaded Chip Carrier OTP (PLCC)
<b>32LW</b>	32 Pad, Windowed, Ceramic Leadless Chip Carrier (LCC)
<b>32P6</b>	32 Lead, 0.600" Wide, Plastic Dual Inline Package OTP (PDIP)
<b>40T</b>	40 Lead, Plastic Thin Small Outline Package OTP (TSOP)



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